PL22V10-12/-15, PL22V10I15

FEATURES

- Advanced CMOS EEPROM technology
- Ultra high performance
- 12ns, and 15ns (t_{PD}) commercial versions
- 15ns (t_{PD}) industrial version
- f_{MAX} as fast as 71.4MHz
- Available in Dual In-Line, Small Outline Large, and Plastic Leaded Chip Carrier packages
- Low power consumption
 - 90mA + 0.5mA/MHz max
- EE reprogrammability
- Low-risk reprogrammable inventory
- Superior programming and functional yield
- 100% testable
- Erases and programs in seconds
- 100 guaranteed erase cycles
- Development and programming support
- Third-party software and programmers
- SLICE development software
- Architectural flexibility
 - 132 product term × 44 input AND array
 - Up to 22 inputs and 10 outputs
 - Variable product term distribution (8 to 16 per output) for greater logic flexibility
 - Independently programmable
 - 4-configuration I/O macrocells
 - Synchronous preset, asynchronous clear
 Independently programmable output enables
- Application versatility
 - Pin-for-pin and JEDEC-file compatible with the bipolar AmPAL22V10, CMOS PALC22V10 and PEEL22CV10A

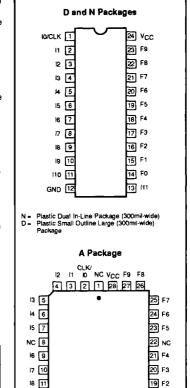
DESCRIPTION

The Philips Semiconductors PL22V10-12 and PL22V10-15 are CMOS programmable electrically erasable logic devices that provide a high-performance, low-power, reprogrammable, and architecturally enhanced alternative to early generation programmable logic devices (PLDs). Designed in advanced CMOS EEPROM technology, the PL22V10 rivals speed parameters of comparable bipolar PLDs while providing a dramatic improvement in active power consumption. The EE reprogrammability of the PL22V10 allows cost effective plastic packaging, low risk inventory, reduced development and retrofit costs, and enhanced testability to ensure 100% field programmability and function. The PL22V10's flexible architecture offers complete function and JEDEC-file compatibility with the bipolar AmPAL22V10 and the CMOS PALC22V10. Applications for the PL22V10 include: replacement of random SSI/MSI logic circuitry and user customized sequential and combinatorial functions such as counters, shift registers, state machines, address decoders, multiplexers, etc. Development and programming support for the PL22V10 is provided by Philips Semiconductors and third-party manufacturers.

PIN LABEL DESCRIPTIONS

l1 l11	Dedicated Input
NC	Not Connected
F0 – F9	Macro Cell Input/Output
CLK/I0	Clock Input/Dedicated Input
Vcc	Supply Voltage
GND	Ground

PIN CONFIGURATIONS



12 13 14 15 16 17 18 19 10 GND NC 111 F0 F1

Plastic Leaded Chip Carrier

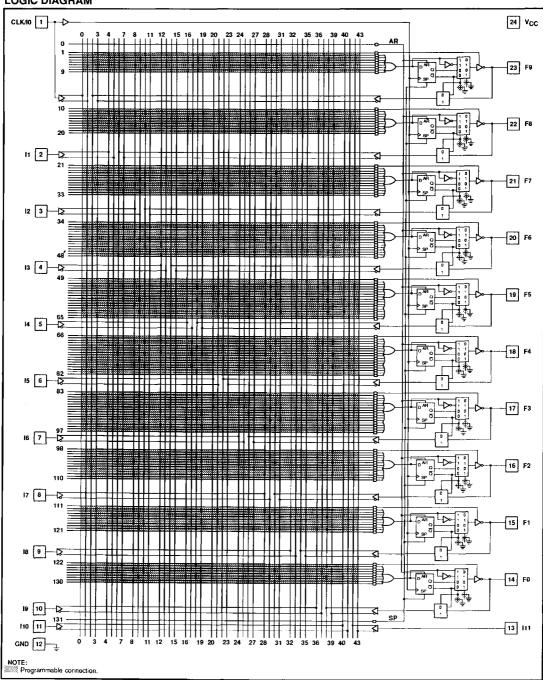
ORDERING INFORMATION

DESCRIPTION	ORDER CODE	DRAWING NUMBER
24-Pin (300mil-wide) Plastic DIP (Dual-In-Line Package)	PL22V10-12N PL22V10-15N PL22V10I15N (Industrial)	0410D
28-Pin (300mil-wide) PLCC (Plastic Leaded Chip Carrier Package)	PL22V10-12A PL22V10-15A PL22V10I15A (Industrial)	0401F
24-Pin (300mil-wide) Plastic SOL (Small Outline Large) Package	PL22V10-10D PL22V10-12D PL22V10-15D PL22V10115D (Industrial)	0173D

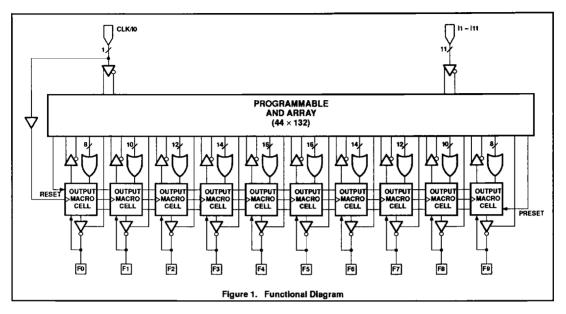
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LOGIC DIAGRAM



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FUNCTION DESCRIPTION

The PL22V10 implements logic functions as sum-of-products expressions in a programmable-AND/fixed-OR logic array. User-defined functions are created by programming the connections of input signals into the array. User-configurable output structures in the form of I/O macrocells further increase logic flexibility.

ARCHITECTURE OVERVIEW

The PL22V10 architecture is illustrated in the Figure 1. Twelve dedicated inputs and 10 I/Os provide up to 22 inputs and 10 outputs for creation of logic functions. At the core of the device is a programmable electrically-erasable AND array which drives a fixed OR array. With this structure, the PL22V10 can implement up to 10 sum-of-products logic expressions.

Associated with each of the 10 OR functions is an I/O macro cell which can be independently programmed to one of 4 different configurations. The programmable macro cells allow each I/O to create sequential or combinatorial logic functions with either Active-High or Active-Low polarity.

AND/OR LOGIC ARRAY

The programmable AND array of the PL22V10 (shown in the Logic Diagram) is formed by input lines intersecting product terms. The input lines and product terms are used as follows:

44 input lines:

- 24 input lines carry the True and Complement of the signals applied to the 12 input pins
- 20 additional lines carry the True and Complement values of feedback or input signals from the 10 I/Os

132 product terms:

- 120 product terms (arranged in 2 groups of 8, 10, 12, 14, and 16) used to form logical sums
- 10 output enable terms (one for each I/O)
- 1 global synchronous preset term
- 1 global asynchronous clear term

At each input-line/product-term intersection there is an EEPROM memory cell which determines whether or not there is a logical connection at that intersection. Each product term is essentially a 44-input AND gate. A

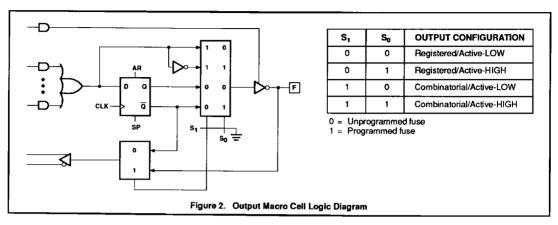
product term which is connected to both the True and Complement of an input signal will always be FALSE, and thus will not effect the OR function that it drives. When all the connections on a product term are opened, a Don't Care state exists and that term will always be TRUE.

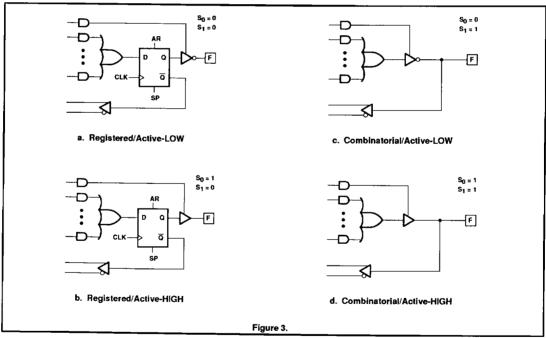
When programming the PL22V10, the device programmer first performs a bulk erase to instantly remove the previous pattern. The erase cycle opens every logical connection in the array. The device is then configured to perform the user-defined function by programming selected connections in the AND array. (Note that EEPROM device programmers automatically program the connections on unused product terms so that they will have no effect on the output function.)

VARIABLE PRODUCT TERM DISTRIBUTION

The PL22V10 provides 120 product terms to drive the 10 OR functions. These product terms are distributed among the outputs in groups of 8, 10, 12, 14, and 16 to form logical sums (see Logic Diagram). This distribution allows optimum use of device resources.

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PROGRAMMABLE I/O MACROCELL

The output macrocell provides complete control over the architecture of each output. The ability to configure each output independently permits users to tailor the configuration of the PL22V10 to the precise requirements of their designs.

MACROCELL ARCHITECTURE

Each I/O macrocell, as shown in Figure 2, consists of a D-type flip-flop and two signal-select multiplexers. The configuration of each macrocell of the PL22V10 is determined by the two EEPROM bits controlling these multiplexers. These bits determine output polarity, and output type (registered or non-registered). Equivalent circuits for the macrocell configurations are illustrated in Figure 3.

OUTPUT TYPE

The signal from the OR array can be fed directly to the output pin (combinatorial function) or latched in the D-type flip-flop (registered function). The D-type flip-flop latches data on the rising edge of the clock and is controlled by the global preset and clear terms. When the synchronous preset term is satisfied, the Q output of the register will be set HIGH at the next rising edge of the clock input. Satisfying the asynchronous clear term will set Q LOW, regardless of the clock state. If both terms are satisfied simultaneously, the clear will override the preset.

PROGRAM/ERASE CYCLES

The PL22V10 is 100% testable, erases/programs in seconds, and has 100 guaranteed erase cycles.

OUTPUT POLARITY

Each macrocell can be configured to implement Active-High or Active-Low logic. Programmable polarity eliminates the need for external inverters.

OUTPUT ENABLE

The output of each I/O macrocell can be enabled or disabled under the control of its associated programmable output enable product term. When the logical conditions programmed on the output enable term are satisfied, the output signal is propagated to the I/O pin. Otherwise, the output buffer is driven into the high-impedance state.

Under the control of the output enable term, the I/O pin can function as a dedicated input, a dedicated output, or a bi-directional I/O. Opening every connection on the output enable term will permanently enable the output buffer and yield a dedicated output. Conversely, if every connection is intact, the enable term will always be logically FALSE and the I/O will function as a dedicated input.

REGISTER FEEDBACK SELECT

When the I/O macrocell is configured to implement a registered function (S1=0) (Figures 3.a or 3.b), the feedback signal to the AND array is taken from the \overline{Q} output.

BI-DIRECTIONAL I/O SELECT

When configuring an I/O macrocell to implement a combinatorial function (S1=1) (Figures 3.c or 3.d), the feedback signal is taken from the I/O pin. In this case, the pin can be used as a dedicated input, a dedicated output, or a bi-directional I/O.

POWER-ON RESET

To ease system initialization, all flip-flops will power-up to a reset condition and the Q output will be low. The actual output of the PL22V10 will depend on the programmed output polarity. The V_{CC} rise must be monotonic and the reset delay time is $5\mu s$ maximum.

DESIGN SECURITY

The PL22V10 provides a special EEPROM security bit that prevents unauthorized reading or copying of designs programmed into the device. The security bit is set by the PLD programmer, either at the conclusion of the programming cycle or as a separate step, after the device has been programmed. Once the security bit is set it is impossible to verify (read) or program the PL22V10 until the entire device has first been erased with the bulk-erase function.

PROGRAM AND ERASE

The PL22V10 can be programmed on standard logic programmers. If a device needs to be reprogrammed, simply place back into the programmer, at which point it will be automatically erased, then repatterned.

Approved programmers are listed in the Philips Semiconductors Programmer Reference Guide.

SOFTWARE SUPPORT

The PL22V10 is fully supported by industry standard (JEDEC compatible) PLD CAD tools, including Phillips Semiconductors' SNAP design software package. ABELIM, CUPLIM, and PALASM® 90 design software packages also support the PL22V10 architecture.

All packages allow Boolean and state equation entry formats. SNAP, ABEL and CUPL also accept, as input, schematic capture format.

PL22V10 logic designs can also be generated using the program table entry format. This program table entry format is supported by SNAP only.

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ABSOLUTE MAXIMUM RATINGS¹

			RA					
SYMBOL	PARAMETER	CONDITIONS	MIN	MAX	UNIT			
V _{CC}	Supply voltage	Relative to GND	-0.5	+7.0	V			
V _{IN} , V _{OUT}	Voltage applied to any pin ³	Relative to GND ²	-1.2	V _{CC} + 0.5	V _{DC}			
l _{out}	Output current	Per pin (I _{OL} , I _{OH})		±25	mA			
T _{stg}	Storage temperature range		65	+125	°C			
T _{LT}	Lead temperature	Soldering 10 seconds	+	+300				

NOTES:

- 1. Stresses above those listed may cause malfunction or permanent damage to the device. This is a stress rating only. Functional operation at these or any other condition above those indicated in the operational and programming specification of the device is not implied.

 Minimum DC input is -0.5V, however inputs may undershoot to -2.0V for periods less than 20ns.

 V_{IN} and V_{OUT} are not specified for program/verify operation.

OPERATING RANGES

			RAT		
SYMBOL	PARAMETER	CONDITIONS	MIN	MAX	UNIT
Vcc	Supply voltage	Commercial ¹	+4.75	+5.25	V _{DC}
		Industrial	+4.5	+5.5	V _{DC}
Tamb	Ambient temperature	Commercial ¹	0	+70	°C
		Industrial	-40	+85	°C
t _R	Clock Rise Time	See note 2		250	ns
t _F	Clock Fall Time	See note 2		250	ns
tavcc	V _{CC} Rise Time	See note 2		250	ms

NOTES:

- Voltage applied to input or output must not exceed V_{CC} +0.3V.
 Test points for Clock and V_{CC} in t_R, t_F, t_{CL}, t_{CH}, and t_{RESET} are referenced at 10% and 90% levels.

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DC ELECTRICAL CHARACTERISTICS

 $\begin{aligned} &\text{Commercial} = ~0^{\circ}\text{C} \leq \text{T}_{\text{amb}} \leq +75^{\circ}\text{C},~4.75\text{V} \leq \text{V}_{\text{CC}} \leq 5.25\text{V};\\ &\text{Industrial} = -40^{\circ}\text{C} \leq \text{T}_{\text{amb}} \leq +85^{\circ}\text{C},~4.5\text{V} \leq \text{V}_{\text{CC}} \leq 5.5\text{V} \end{aligned}$

		_	LIMITS									
SYMBOL	PARAMETER	CONDITIONS	MIN	TYP ⁴	MAX	UNIT						
Input volt	age				-							
V _{IL}	Low		-0.3		0.8	٧						
V_{iH}	High		2.0		V _{CC} + 0.3	٧						
Output vo	oltage											
V _{OL}	Low – TTL	V _{CC} = MIN, I _{OL} = 16mA			0.5	\ v						
Volc	Low - CMOS	V _{CC} = MIN, I _{OL} = 10μA			0.1	V						
V_{OH}	High – TTL	V _{CC} = MiN, I _{OH} = -4.0mA	2.4			V						
V _{OHC}	High - CMOS	V _{CC} = MiN, I _{OH} = -10μA	$V_{CC} = 0.1$	_		٧						
Input cur	rent											
I _{IL} /I _{IH}	Input leakage current	V _{CC} = MAX, GND ≤ V _{IN} ≤ V _{CC}		1	±10	μA						
Output cu	urrent	<u> </u>										
loz	Output leakage	I/O = Hi-Z, GND ≤ V _O ≤ V _{CC}	-	2	±10	μА						
l _{SC} ⁵	Short circuit	V _{CC} = 5V, V _{OUT} = 0.5V ¹	-30		-130	mA						
Icc	V _{CC} active current, CMOS (commercial)	V _{IN} = V _{CC} or GND ^{2, 3}		70 + 0.5mA/MHz	90 + 0.5m A /MHz	mA						
	V _{CC} active current, CMOS (industrial)	V _{IN} = V _{CC} or GND ^{2, 3}		80 + 0.5mA/MHz	100 + 0.5mA/MHz	mA						
	V _{CC} active current, TTL (commercial)	V _{IN} = V _{IL} or V _{IH} ^{2, 3}		80 + 0.5m A/M Hz	100 + 0.5mA/MHz	mA						
	V _{CC} active current, TTL (industrial)	V _{IN} = V _{IL} or V _{IH} ^{2, 3}		90 + 0.5mA/MHz	110 + 0.5mA/MHz	mA						

NOTES:

- 1. No more than one output should be tested at a time. Duration of the short-circuit test should not exceed one second.
- I/O pins open (no load).
 I/O pins open (no load).
 I_{CC} for a typical application: This parameter is tested with the device programmed as a 10-bit Counter.
 Typical values are at V_{CC} = 5V. Typical values are guaranteed by design.
 Room temperature only.

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AC ELECTRICAL CHARACTERISTICS

 $Commercial = 0 ^{o}C \leq T_{amb} \leq +75 ^{o}C, \ 4.75V \leq V_{CC} \leq 5.25V^{1,\,2};$ Industrial = -40°C $\leq T_{amb} \leq +85$ °C, 4.5V $\leq V_{CC} \leq 5.5$ V

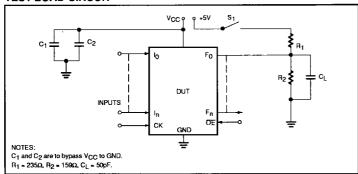
		TEST	PL22\	/10-12		/10-15 /10I15	
SYMBOL	PARAMETER	CONDITIONS	MIN	MAX	MIN	MAX	UNIT
₽D	Input ³ to non-registered output	50pF	ŀ	12		15	ns
t _{EA}	Input ³ to Output Enable ⁴	50pF		12		15	ns
t _{ER}	Input ³ to Output Disable ⁴	5pF		12		15	ns
tco	Clock to output	50pF		9		10	ns
t _{CO2}	Clock to combinatorial output delay via internal registered feedback	50pF		16		19	ns
t _S	Input ³ or feedback setup to clock	50pF	8		10		ns
t _{SF}	Internal feedback ⁶	50pF	6		9		ns
t _H	Input ³ hold after clock	50pF	0		0		ns
t _{WL} , t _{WH}	Clock width – clock low time, clock high time ⁵	50pF	7		8		ns
t _{CP}	MIN clock period External (t _S + t _{CO})	50pF	17		20		ns
f _{MAX1}	MAX operating frequency;	50ρF	66.7		52.6		MHz
f _{MAX2}	MAX operating frequency; External (1/t _{CP})	50pF	58.8		50.0		MHz
f _{MAX3}	$\begin{array}{ccc} \text{MAX clock frequency;} & & & \left(\frac{1}{t_{\text{WL}} + t_{\text{WH}}}\right) \end{array}$	50pF	71.4		62.5		MHz
t _{ARW}	Asynchronous Reset pulse width	50pF	12		15		ns
t _{AR}	Input ³ to Asynchronous Reset	50pF		15		18	ns
tarr	Asynchronous Reset recovery time	50pF	10		10		ns
t _{SPR}	Synchronous Preset recovery time	50pF	10		10		ns
t _{RESET}	Power-on reset time for registers in clear state ⁵	50pF		5		5	μs
Capacitano	ce ⁶		-	•			
C _{IN}	Input Capacitance ⁷	$T_{amb} = 25$ °C, $V_{CC} = 5.0$ V		6		6	pF
C _{OUT}	Output Capacitance ⁷	@ f = 1MHz		12		12	рF

NOTES:

- 1. Test conditions assume: signal transition times of 2.5ns or less from the 10% and 90% points, timing reference levels of 1.5V (unless otherwise
- 2. Device test loads are specified at the end of this section.
- 3. "Input" refers to an Input pin signal.

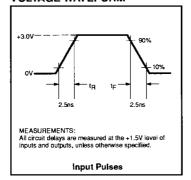
- to is measured from input transition to V_{RF} ± 0.1V, to_D is measured from input transition to V_{OH} 0.1V or V_{OL} + 0.1V.
 Test points for Clock and V_{CC} in t_R, t_F, t_{CL}, t_{CH}, and t_{RESET} are referenced at 10% and 90% levels.
 Parameters are not 100% tested. Specifications are based on initial characterization and are tested after any design or process modification. which may affect operational frequency.
- 7. Capacitances are tested on a sample basis.

TEST LOAD CIRCUIT



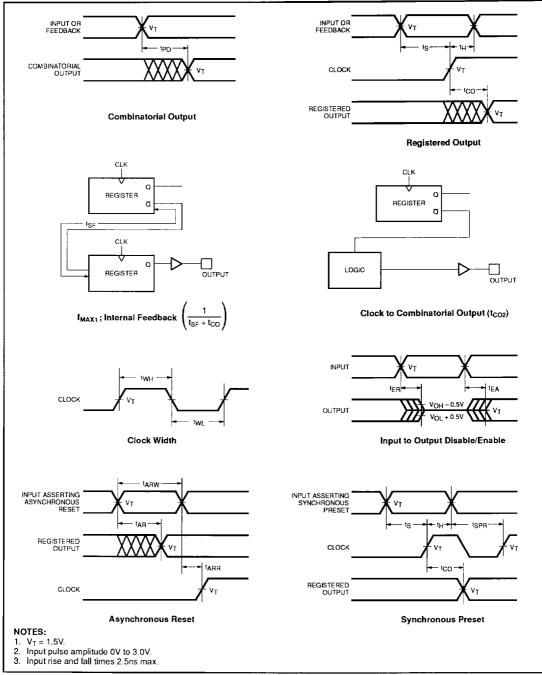
THEVENIN EQUIVALENT

VOLTAGE WAVEFORM



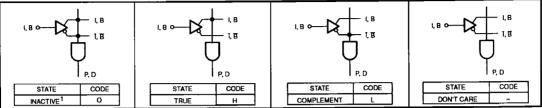
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SWITCHING WAVEFORMS



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NOTE:

1. This is the initial state.

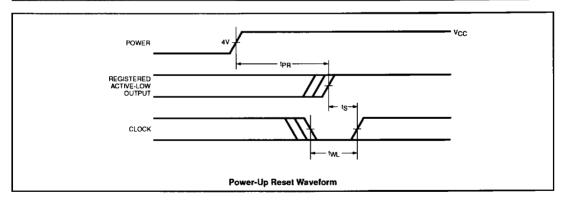
POWER-UP RESET

The power-up reset feature ensures that all flip-flops will be reset to LOW after the device has been powered up. The output state will depend on the programmed pattern. This feature is valuable in simplifying state machine initialization. A timing diagram and

parameter table are shown below. Due to the synchronous operation of the power-up reset and the wide range of ways $V_{\rm CC}$ can rise to its steady state, two conditions are required to ensure a valid power-up reset. These conditions are:

- 1. The V_{CC} rise must be monotonic.
- Following reset, the clock input must not be driven from LOW to HIGH until all applicable input and feedback setup times are met

		LIM		
SYMBOL	PARAMETER	MIN	MAX	UNIT
ŧРЯ	Power-up Reset Time		1	μs
ts, tsf	Input or Feedback Setup Time	S	ee AC Electric	al
t _{WL}	Clock Width LOW		Characteristic	S

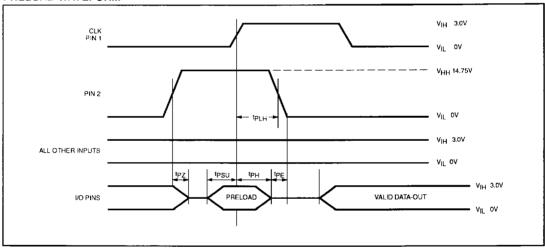


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PRELOAD TEST CONDITION

				LIMITS		
SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
t _{PE}	Valid data out			100		ns
t _{PZ}	Output 3-State delay time after assertion of Preload (Pin 2 = V _{HH})			100		ns
t _{PH}	Hold time of all preload inputs with respect to Clock rising edge			15		ns
t _{PSU}	Setup time of all preload inputs with respect to Clock rising edge			100		ns
t _{PLH}	Hold time for Preconditioning input			50		ns
V _{HH}	Preload enable voltage		14.50	14.75	15.0	٧

PRELOAD WAVEFORM



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SNAP RESOURCE SUMMARY DESIGNATIONS

